Notice of References Cited Application/Control No. 10/578,932 Examiner MARCOS BATISTA Applicant(s)/Patent Under Reexamination DU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0134650 A1	07-2003	Sundar et al.	455/465
*	В	US-2005/0053034 A1	03-2005	Chiueh, Tzi-cker	370/331
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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